**TRIBOELECTRIC NANOGENERATORS: INSIGHTS FROM A SYSTEMATIC BIBLIOMETRIC ANALYSIS OF REVIEW ARTICLE (2021)**

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**Abstract**

The development of triboelectric nanogenerators (TENGs) in the Internet of Things (IoT) has attracted wide attention since it has greater efforts on achieving Sustainable Renewable Energy Sources. Disposable batteries are strongly linked to e-waste, thus enhancing the deployment of self–powered batteries pave the way for energy source. In this study, bibliometric analysis has been performed on Review papers in the subject of TENG using the Scopus database in the year 2021. The findings reveal an increasing number of researches, in which most of the published articles originate from the China, United States, and other developed countries; nevertheless, several emerging countries are also contributing. China appears to be the most active participant in this research field among them. This bibliometric analysis can provide the direction to industry practitioners and renewable energy policymakers understand the advancements, evaluate the state-of-the-art, and identify research gaps by undertaking a comprehensive review of current research.

**Keywords:** Triboelectric Nanogenerator; Internet of Things; Bibliometric analysis